

Search Notes

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Examiner

Leith A. Al-Nazer

Applicant(s)/Patent under
Reexamination

HWANG ET AL.

Art Unit

2821

SEARCHED

Class	Subclass	Date	Examiner
343	767, 770, 700MS	7/15/2005	LA

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
343	767, 770	7/15/2005	LA
343	700MS	7/15/2005	LA

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Updated EAST text search (see "Examiner Search Notes")	7/15/2005	LA
Consulted with primary examiner Tan Ho	7/15/2005	LA